

Supporting Information for

Fabrication and investigation of 26NCA films exhibiting tunable blue fluorescence based on LVPVDM

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Structural study and surface morphology of single-component metallic In film

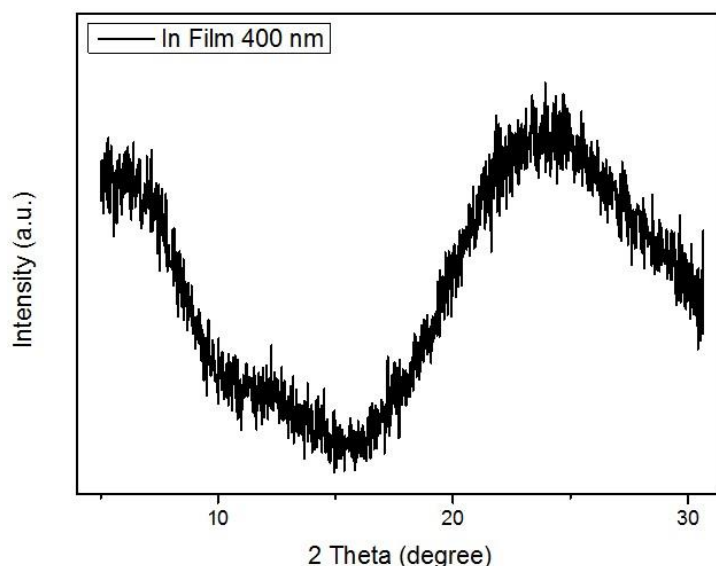


Figure S1. XRD pattern of 400 nm In film.

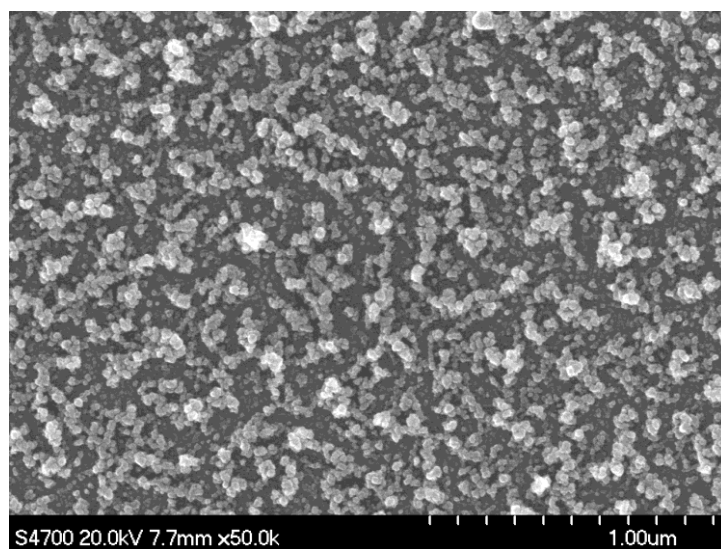


Figure S2. SEM image of 400 nm In film.

Structural study and surface morphology of single-component organic 26NCA films

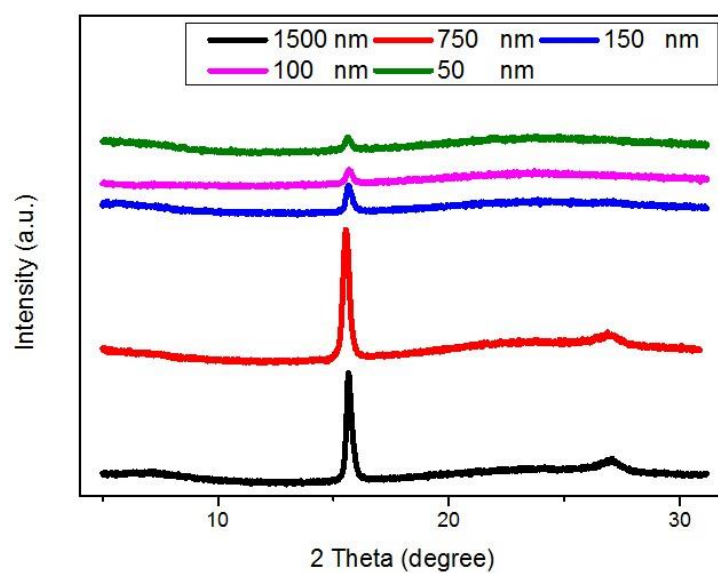


Figure S3. XRD patterns of 26NCA films with different thickness.

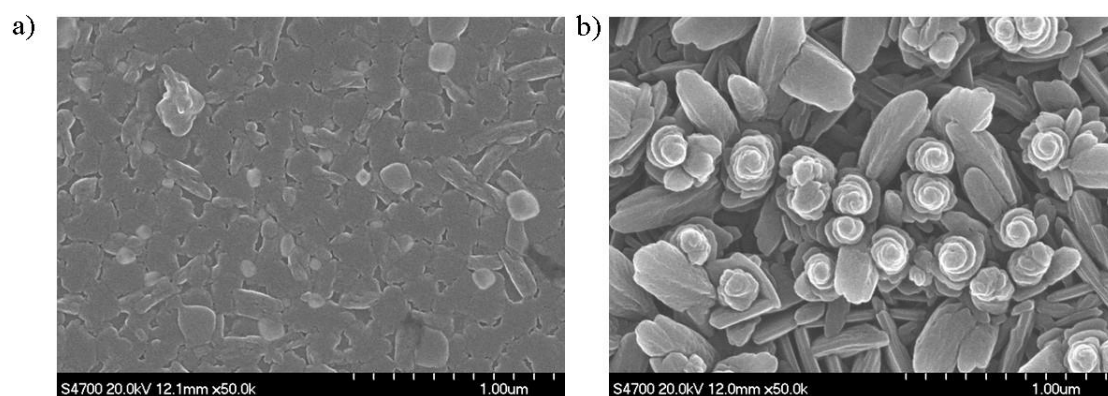


Figure S4. SEM images of 26NCA films (left: 50 nm and right: 1500 nm).

Structural study and surface morphology of two-component 26NCA/In layer films

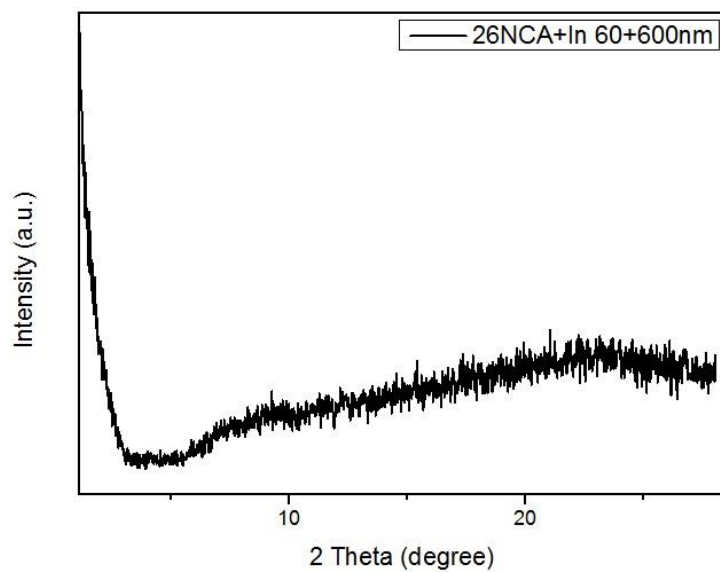


Figure S5. XRD pattern of 60 nm/600 nm 26NCA/In layer film.

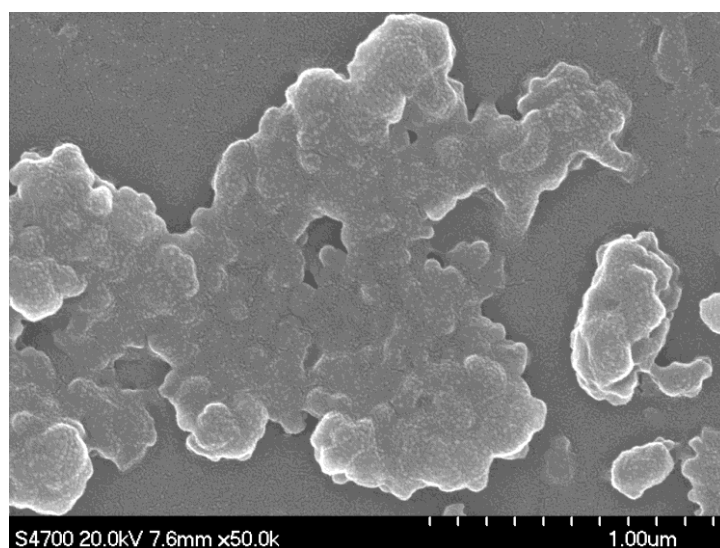


Figure S6. SEM image of 60 nm/600 nm 26NCA/In layer film.

Structural study and surface morphology of two-component 26NCA/OFN films

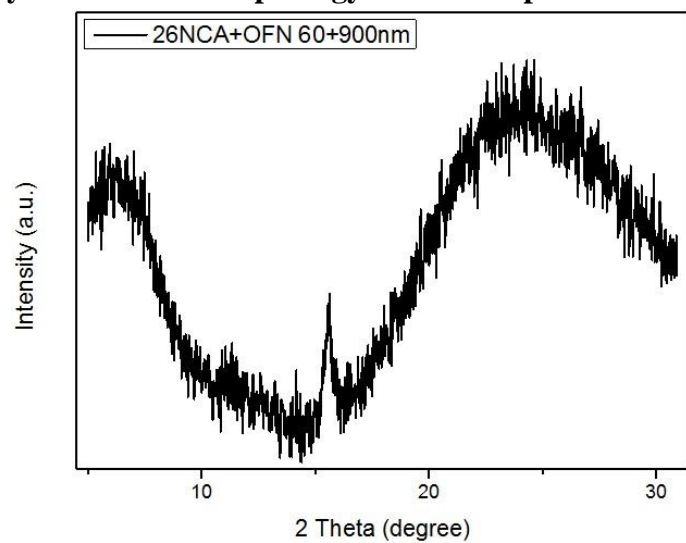


Figure S7. XRD pattern of 60 nm/900 nm 26NCA/OFN layer film.

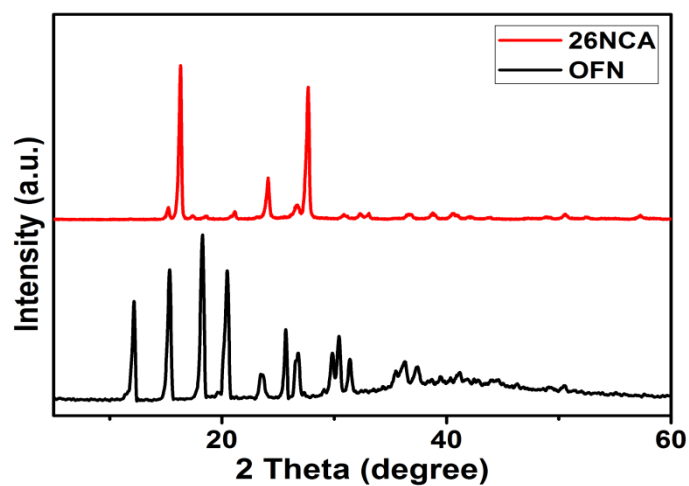


Figure S8. XRD patterns of pristine 26NCA and OFN.

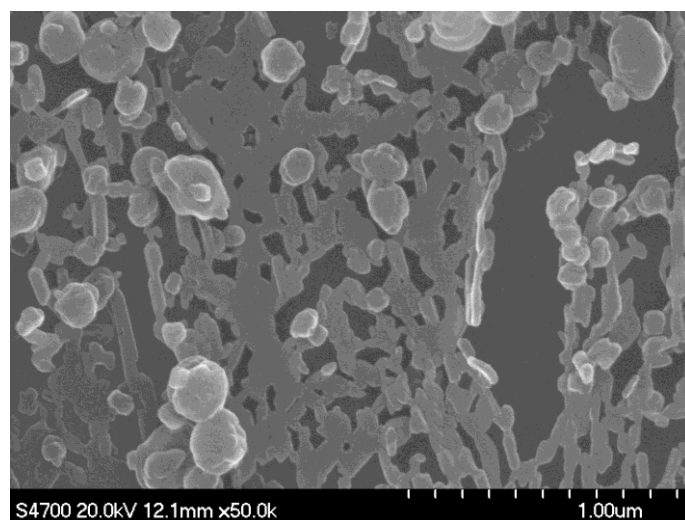


Figure S9. SEM image of 60 nm/900 nm 26NCA/OFN layer film.

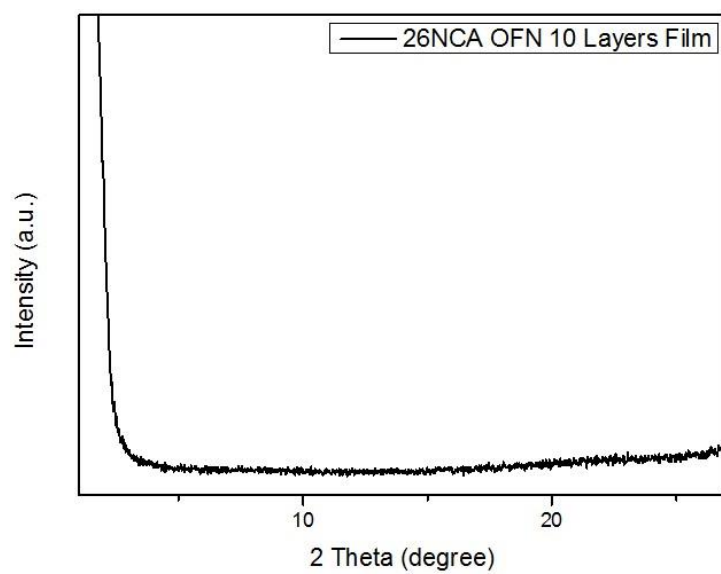


Figure S10. XRD pattern of 26NCA/OFN 10 layers film.

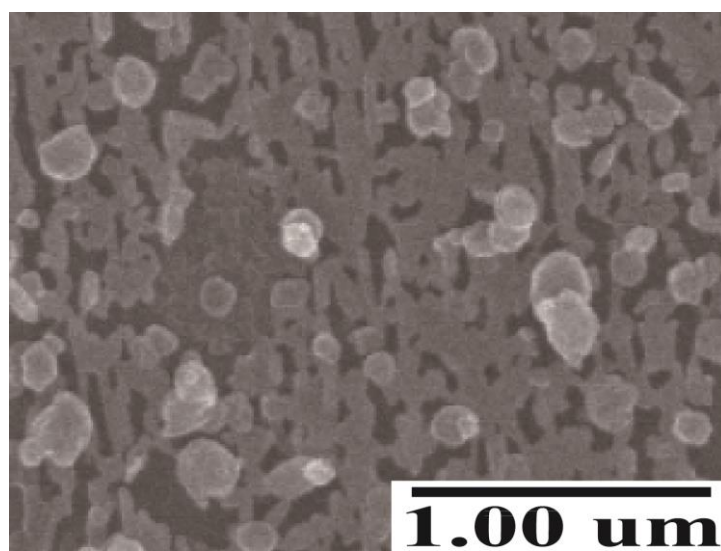


Figure S11. SEM image of 26NCA/OFN 10 layers film.